# Self-Protected Low Side Driver with Temperature and Current Limit

# NCV8402, NCV8402A

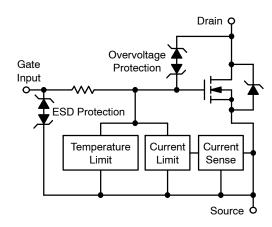
NCV8402/A is a three terminal protected Low–Side Smart Discrete device. The protection features include overcurrent, overtemperature, ESD and integrated Drain–to–Gate clamping for overvoltage protection. This device offers protection and is suitable for harsh automotive environments.

#### **Features**

- Short-Circuit Protection
- Thermal Shutdown with Automatic Restart
- Overvoltage Protection
- Integrated Clamp for Inductive Switching
- ESD Protection
- NCV8402AMNWT1G Wettable Flanks Product
- dV/dt Robustness
- Analog Drive Capability (Logic Level Input)
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

### **Typical Applications**

- Switch a Variety of Resistive, Inductive and Capacitive Loads
- Can Replace Electromechanical Relays and Discrete Circuits
- Automotive / Industrial





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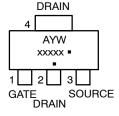
V <sub>(BR)DSS</sub> (Clamped)	R <sub>DS(ON)</sub> TYP	I <sub>D</sub> MAX
42 V	165 mΩ @ 10 V	2.0 A*

<sup>\*</sup>Max current limit value is dependent on input condition.

#### **MARKING DIAGRAMS**



SOT-223 CASE 318E STYLE 3





DFN6 CASE 506AX





DFN6 (WF) CASE 506DK



A = Assembly Location

Y = Year

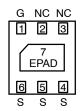
W or WW = Work Week

xxxxx = V8402 or 8402A

= Pb-Free Package

(Note: Microdot may be in either location)

#### **DFN6 PACKAGE PIN DESCRIPTION**



Pin#	Symbol	Description
1	G	Gate Input
2	NC	No Connect
3	NC	No Connect
4	S*	Source
5	S*	Source
6	S*	Source
7	EPAD	Drain

\*Pins 4, 5, 6 are internally shorted together. It is recommended to short these pins externally.

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 11 of this data sheet.

## **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

	Rating		Symbol	Value	Unit
Drain-to-Source Voltage Internally Clamped			$V_{DSS}$	42	V
Drain-to-Gate Voltage Internally C	lamped	$(R_G = 1.0 M\Omega)$	$V_{DGR}$	42	V
Gate-to-Source Voltage			$V_{GS}$	±14	V
Continuous Drain Current			I <sub>D</sub>	Internally L	imited
Total Power Dissipation – SOT–223 Version @ $T_A$ = 25°C (Note 1) @ $T_A$ = 25°C (Note 2) @ $T_S$ = 25°C)		P <sub>D</sub>	1.1 1.74 8.9	W	
@ T <sub>A</sub> = 2		@ T <sub>A</sub> = 25°C (Note 1) @ T <sub>A</sub> = 25°C (Note 2) @ T <sub>S</sub> = 25°C)	P <sub>D</sub>	0.76 1.78 8.9	W
@ T <sub>A</sub> = 25		@ T <sub>A</sub> = 25°C (Note 1) @ T <sub>A</sub> = 25°C (Note 2) @ T <sub>S</sub> = 25°C)	Ι <sub>D</sub>	1.54 1.94 6.75	Α
Maximum Continuous Drain Current – DFN Version @ $T_A = 25^{\circ}C$ (Note 1) @ $T_A = 25^{\circ}C$ (Note 2) @ $T_S = 25^{\circ}C$ )			l <sub>D</sub>	1.28 1.97 6.75	Α
Thermal Resistance	SOT223 Junction-to-	-Ambient Steady State (Note 1) -Ambient Steady State (Note 2) o-Soldering Point Steady State	$egin{array}{l} R_{ hetaJA} \ R_{ hetaJS} \end{array}$	114 72 14	°C/W
DFN Junction-to-Ambient Steady State (Note 1) DFN Junction-to-Ambient Steady State (Note 2) DFN Junction-to-Soldering Point Steady State			$egin{array}{l} R_{ hetaJA} \ R_{ hetaJS} \end{array}$	163 70 14	
Single Pulse Drain-to-Source Avalar ( $V_{DD} = 32 \text{ V}, V_{G} = 5.0 \text{ V}, I_{PK} = 1.0 \text{ A}$			E <sub>AS</sub>	150	mJ
Load Dump Voltage $(V_{GS} = 0 \text{ and } 10 \text{ V}, R_I = 2.0 \Omega, R_L = 9.0 \Omega, t_d = 400 \text{ ms})$		$V_{LD}$	55	V	
Operating Junction Temperature			TJ	-40 to 150	°C
Storage Temperature			T <sub>stg</sub>	-55 to 150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface–mounted onto min pad FR4 PCB, (2 oz. Cu, 0.06" thick).

2. Surface–mounted onto 2" sq. FR4 board (1" sq., 1 oz. Cu, 0.06" thick).

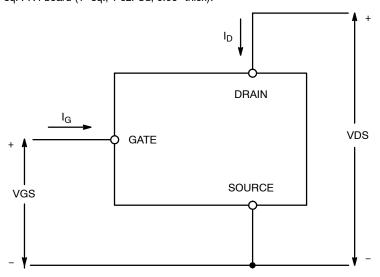


Figure 1. Voltage and Current Convention

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter Parameter	Test Condition	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS		,	l			
Drain-to-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 10 mA, T <sub>J</sub> = 25°C	V <sub>(BR)DSS</sub>	42	46	55	V
(Note 3)	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 10 mA, T <sub>J</sub> = 150°C (Note 5)	(BH)DOG	40	45	55	
Zero Gate Voltage Drain Current	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 32 V, T <sub>J</sub> = 25°C	I <sub>DSS</sub>		0.25	4.0	μΑ
Zero Gate Voltage Drain Current	$V_{GS} = 0 \text{ V}, V_{DS} = 32 \text{ V}, T_{J} = 150^{\circ}\text{C}$ (Note 5)	I <sub>DSS</sub>		1.1	20	μΑ
Gate Input Current	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 5.0 V	I <sub>GSSF</sub>		50	100	μΑ
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 150 \mu A$	V <sub>GS(th)</sub>	1.3	1.8	2.2	V
Gate Threshold Temperature Coefficient		V <sub>GS(th)</sub> /T <sub>J</sub>		4.0		-mV/°C
Static Drain-to-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.7 A, T <sub>J</sub> = 25°C	R <sub>DS(on)</sub>		165	200	mΩ
	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.7 A, T <sub>J</sub> = 150°C (Note 5)			305	400	
	$V_{GS} = 5.0 \text{ V}, I_D = 1.7 \text{ A}, T_J = 25^{\circ}\text{C}$			195	230	
	V <sub>GS</sub> = 5.0 V, I <sub>D</sub> = 1.7 A, T <sub>J</sub> = 150°C (Note 5)			360	460	
	V <sub>GS</sub> = 5.0 V, I <sub>D</sub> = 0.5 A, T <sub>J</sub> = 25°C			190	230	
	$V_{GS} = 5.0 \text{ V}, I_D = 0.5 \text{ A}, T_J = 150^{\circ}\text{C}$ (Note 5)			350	460	
Source-Drain Forward On Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 7.0 A	V <sub>SD</sub>		1.0		V
SWITCHING CHARACTERISTICS (Note	5)					
Turn-On Time (10% V <sub>IN</sub> to 90% I <sub>D</sub> )		t <sub>on</sub>		25	30	μs
Turn-Off Time (90% V <sub>IN</sub> to 10% I <sub>D</sub> )		t <sub>off</sub>		120	200	μs
Turn-On Rise Time (10% I <sub>D</sub> to 90% I <sub>D</sub> )	V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 12 V,	t <sub>rise</sub>		20	25	μs
Turn–Off Fall Time (90% $I_D$ to 10% $I_D$ )	$I_D = 2.5 \text{ A}, R_L = 4.7 \Omega$	t <sub>fall</sub>		50	70	μs
Slew-Rate ON (70% to 50% V <sub>DD</sub> )		-dV <sub>DS</sub> /dt <sub>ON</sub>		0.8	1.2	V/μs
Slew-Rate OFF (50% to 70% V <sub>DD</sub> )		dV <sub>DS</sub> /dt <sub>OFF</sub>		0.3	0.5	V/μs
SELF PROTECTION CHARACTERISTIC	CS (T <sub>J</sub> = 25°C unless otherwise noted) (	Note 4)				
Current Limit	$V_{DS} = 10 \text{ V}, V_{GS} = 5.0 \text{ V}, T_{J} = 25^{\circ}\text{C}$	I <sub>LIM</sub>	3.7	4.3	5.0	Α
	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 5.0 V, T <sub>J</sub> = 150°C (Note 5)		2.3	3.0	3.7	
	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 10 V, T <sub>J</sub> = 25°C		4.2	4.8	5.4	
	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 10 V, T <sub>J</sub> = 150°C (Note 5)		2.7	3.6	4.5	
Temperature Limit (Turn-off)	V <sub>GS</sub> = 5.0 V (Note 5)	T <sub>LIM(off)</sub>	150	175	200	°C
Thermal Hysteresis	V <sub>GS</sub> = 5.0 V	$\Delta T_{LIM(on)}$		15		
Temperature Limit (Turn-off)	V <sub>GS</sub> = 10 V (Note 5)	T <sub>LIM(off)</sub>	150	165	185	
Thermal Hysteresis	V <sub>GS</sub> = 10 V	$\Delta T_{LIM(on)}$		15		<u></u>
GATE INPUT CHARACTERISTICS (Note	9 5)					
Device ON Gate Input Current	V <sub>GS</sub> = 5 V I <sub>D</sub> = 1.0 A	I <sub>GON</sub>		50		μΑ
	V <sub>GS</sub> = 10 V I <sub>D</sub> = 1.0 A			400		
Current Limit Gate Input Current	V <sub>GS</sub> = 5 V, V <sub>DS</sub> = 10 V	I <sub>GCL</sub>		0.05		mA
	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 10 V			0.4		

- Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
   Fault conditions are viewed as beyond the normal operating range of the part.
   Not subject to production testing.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Test Condition	Symbol	Min	Тур	Max	Unit
GATE INPUT CHARACTERISTICS (Note						
Thermal Limit Fault Gate Input Current	V <sub>GS</sub> = 5 V, V <sub>DS</sub> = 10 V	I <sub>GTL</sub>		0.15		mA
	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 10 V			0.7		
ESD ELECTRICAL CHARACTERISTICS (T <sub>J</sub> = 25°C unless otherwise noted) (Note 5)						
Electro-Static Discharge Capability	Human Body Model (HBM)	ESD	4000			V
	Machine Model (MM)		400			

- 3. Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%.
- 4. Fault conditions are viewed as beyond the normal operating range of the part.
  5. Not subject to production testing.

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL PERFORMANCE CURVES**

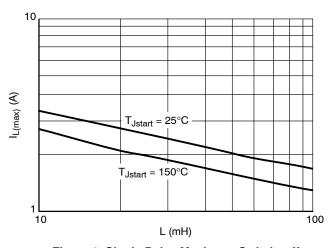


Figure 2. Single Pulse Maximum Switch-off Current vs. Load Inductance

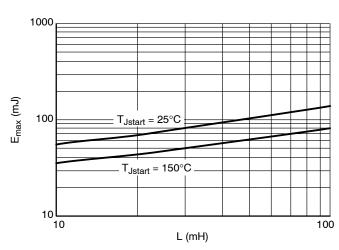


Figure 3. Single Pulse Maximum Switching Energy vs. Load Inductance

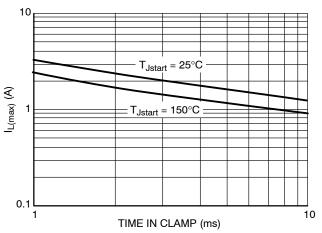


Figure 4. Single Pulse Maximum Inductive Switch-off Current vs. Time in Clamp

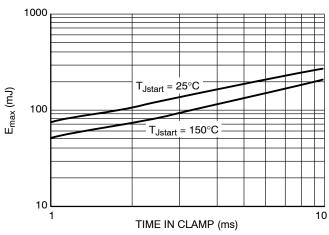


Figure 5. Single Pulse Maximum Inductive Switching Energy vs. Time in Clamp

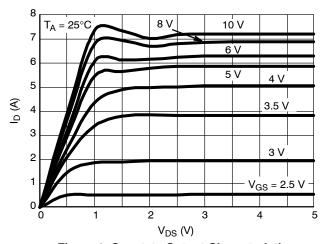


Figure 6. On-state Output Characteristics

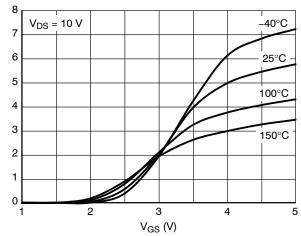


Figure 7. Transfer Characteristics

I<sub>D</sub> (A)

#### **TYPICAL PERFORMANCE CURVES**

I⊔M (A)

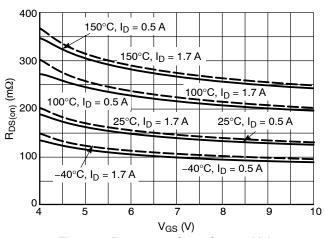


Figure 8.  $R_{DS(on)}$  vs. Gate-Source Voltage

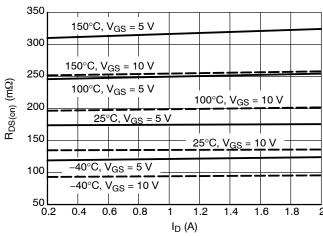


Figure 9. R<sub>DS(on)</sub> vs. Drain Current

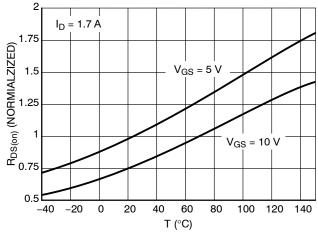


Figure 10. Normalized R<sub>DS(on)</sub> vs. Temperature

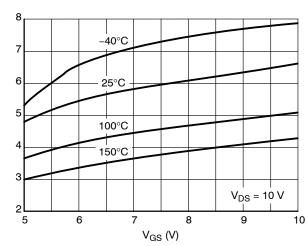


Figure 11. Current Limit vs. Gate-Source Voltage

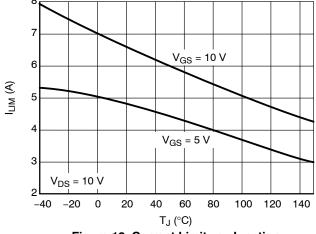


Figure 12. Current Limit vs. Junction Temperature

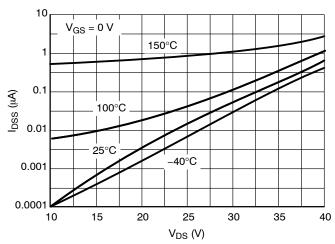


Figure 13. Drain-to-Source Leakage Current

### **TYPICAL PERFORMANCE CURVES**

DRAIN-SOURCE VOLTAGE SLOPE (V/µs)

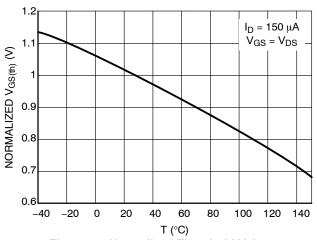


Figure 14. Normalized Threshold Voltage vs. Temperature

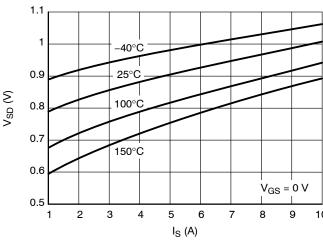


Figure 15. Source-Drain Diode Forward Characteristics

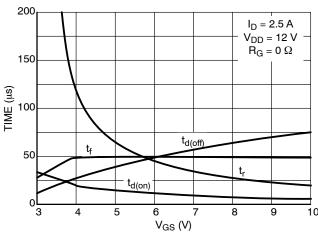


Figure 16. Resistive Load Switching Time vs.

Gate-Source Voltage

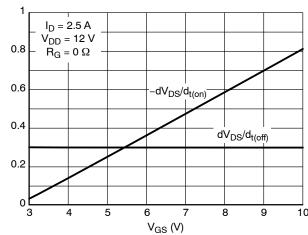


Figure 17. Resistive Load Switching
Drain-Source Voltage Slope vs. Gate-Source
Voltage

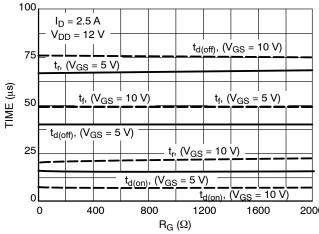


Figure 18. Resistive Load Switching Time vs.
Gate Resistance

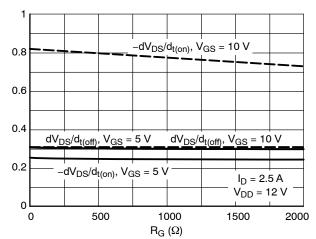


Figure 19. Drain-Source Voltage Slope during Turn On and Turn Off vs. Gate Resistance

DRAIN-SOURCE VOLTAGE SLOPE (V/μs)

#### **TYPICAL PERFORMANCE CURVES**

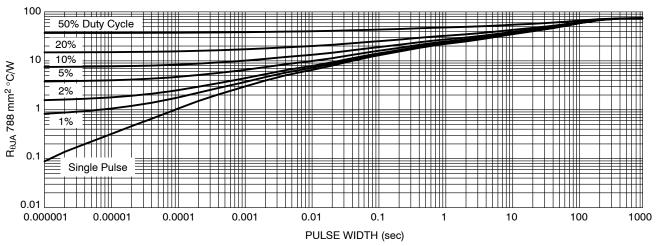


Figure 20. Transient Thermal Resistance - SOT-223 Package

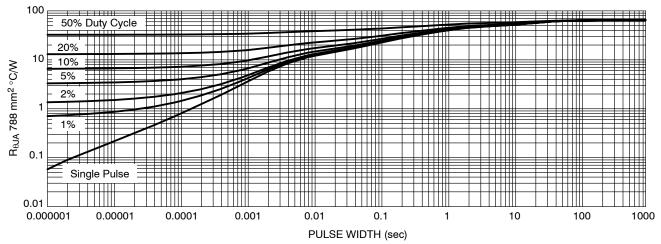


Figure 21. Transient Thermal Resistance - DFN Package

# **TEST CIRCUITS AND WAVEFORMS**

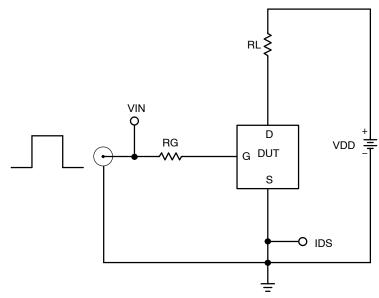


Figure 22. Resistive Load Switching Test Circuit

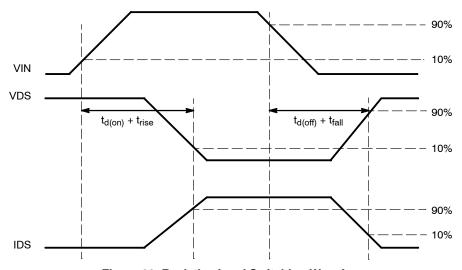


Figure 23. Resistive Load Switching Waveforms

## **TEST CIRCUITS AND WAVEFORMS**

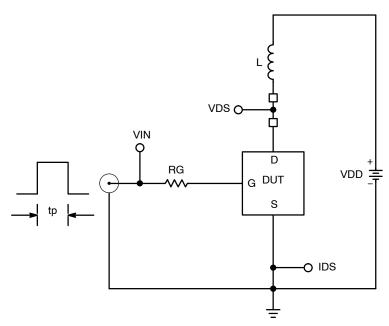


Figure 24. Inductive Load Switching Test Circuit

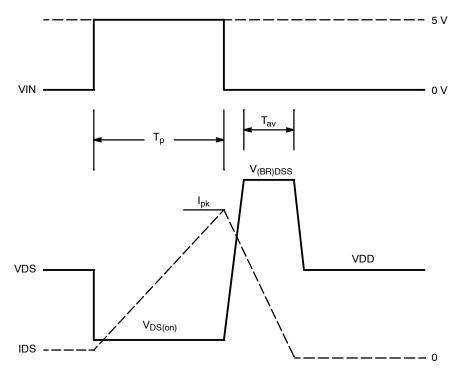


Figure 25. Inductive Load Switching Waveforms

### **ORDERING INFORMATION**

Device*	Package	Shipping <sup>†</sup>
NCV8402STT1G	SOT-223	1000 / Tape & Reel
NCV8402ASTT1G	(Pb-Free)	
NCV8402STT3G	SOT-223	4000 / Tape & Reel
NCV8402ASTT3G	(Pb-Free)	
NCV8402AMNT2G	DFN6 (Pb-Free)	2000 / Tape & Reel
NCV8402AMNWT1G	DFN6 (Pb-Free, Wettable Flank)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.
\*NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP

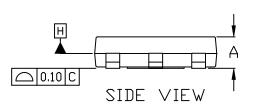
Capable.

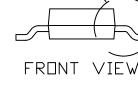


**SOT-223 (TO-261)** CASE 318E-04 ISSUE R

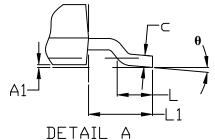
**DATE 02 OCT 2018** 







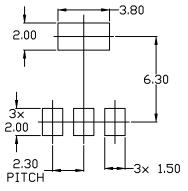
SEE DETAIL A



#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS D & E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
  MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.200MM PER SIDE.
- 4. DATUMS A AND B ARE DETERMINED AT DATUM H.
- 5. ALLIS DEFINED AS THE VERTICAL DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT OF THE PACKAGE BODY.
- 6. POSITIONAL TOLERANCE APPLIES TO DIMENSIONS 6 AND 61.

	MILLIMETERS			
DIM	MIN.	N□M.	MAX.	
Α	1.50	1.63	1.75	
A1	0.02	0.06	0.10	
b	0.60	0.75	0.89	
b1	2.90	3.06	3.20	
C	0.24	0.29	0.35	
D	6.30	6.50	6.70	
E	3.30	3.50	3.70	
е		2,30 BSC	,	
L	0.20			
L1	1.50	1.75	2.00	
He	6.70	7.00	7.30	
θ	0°		10°	



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DESCRIPTION:	SOT-223 (TO-261)		PAGE 1 OF 2

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### **SOT-223 (TO-261)** CASE 318E-04 ISSUE R

**DATE 02 OCT 2018** 

STYLE 1: PIN 1. BASE 2. COLLECTOR 3. EMITTER 4. COLLECTOR	STYLE 2: PIN 1. ANODE 2. CATHODE 3. NC 4. CATHODE	STYLE 3: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN	STYLE 4: PIN 1. SOURCE 2. DRAIN 3. GATE 4. DRAIN	STYLE 5: PIN 1. DRAIN 2. GATE 3. SOURCE 4. GATE
STYLE 6: PIN 1. RETURN 2. INPUT 3. OUTPUT 4. INPUT	STYLE 7: PIN 1. ANODE 1 2. CATHODE 3. ANODE 2 4. CATHODE	STYLE 8: CANCELLED	STYLE 9: PIN 1. INPUT 2. GROUND 3. LOGIC 4. GROUND	STYLE 10: PIN 1. CATHODE 2. ANODE 3. GATE 4. ANODE
STYLE 11: PIN 1. MT 1 2. MT 2 3. GATE 4. MT 2	STYLE 12: PIN 1. INPUT 2. OUTPUT 3. NC 4. OUTPUT	STYLE 13: PIN 1. GATE 2. COLLECTOR 3. EMITTER 4. COLLECTOR		

# GENERIC MARKING DIAGRAM\*



A = Assembly Location

Y = Year W = Work Week

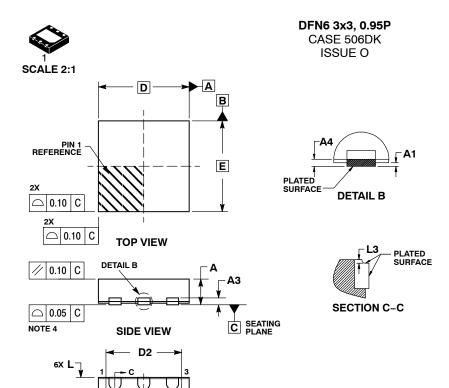
XXXXX = Specific Device Code

= Pb-Free Package

(Note: Microdot may be in either location)
\*This information is generic. Please refer to
device data sheet for actual part marking.
Pb-Free indicator, "G" or microdot "•", may
or may not be present. Some products may
not follow the Generic Marking.

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F2

Ф

0.10 C A B

0.05 C NOTE 3

**DATE 23 JUN 2016** 

#### NOTES:

- NOTES:

  1. DIMENSIONS AND TOLERANCING PER ASME Y14.5M, 1994.

  2. CONTROLLING DIMENSION: MILLIMETERS.

  3. DIMESNION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.20 MM FROM THE TERMINAL TIP.

  4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS			
DIM	MIN	MAX		
Α	0.75	0.95		
<b>A</b> 1	0.00	0.05		
А3	0.20	REF		
A4	0.05	0.15		
b	0.35	0.45		
D	3.00	BSC		
D2	2.40	2.60		
Е	3.00	BSC		
E2	1.50	1.70		
е	0.95 BSC			
L	0.30	0.50		
13	0.00	0.10		

### **GENERIC MARKING DIAGRAM\***



XXXXX = Specific Device Code

Α = Assembly Location

= Wafer Lot L γ = Year

W = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

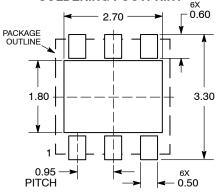
\*This information is generic. Please refer to device data sheet for actual part marking.

Pb-Free indicator, "G" or microdot " ■", may or may not be present.

#### RECOMMENDED **SOLDERING FOOTPRINT\***

**BOTTOM VIEW** 

е

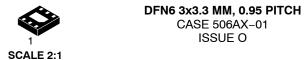


DIMENSIONS: MILLIMETERS

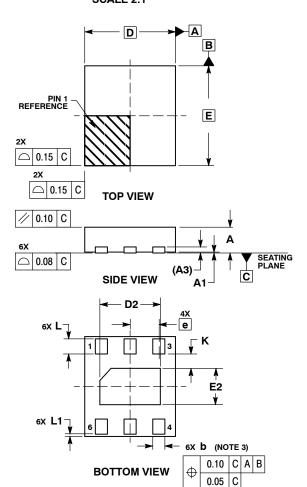
\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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**DATE 20 JAN 2006** 



#### NOTES:

- NOTES:

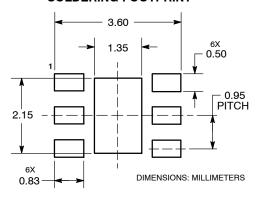
  1. DIMENSIONS AND TOLERANCING PER ASME Y14.5M, 1994.

  2. CONTROLLING DIMENSION: MILLIMETERS.

  3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 mm FROM TERMINAL
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS		
DIM	MIN	NOM	MAX
Α	0.80		0.90
A1	0.00	-	0.05
А3	0.20 REF		
b	0.30		0.40
D	3.00 BSC		
D2	1.90		2.10
Е	3.30 BSC		
E2	1.10		1.30
е	0.95 BSC		
K	0.20		
L	0.40		0.60
L1	0.00		0.15

#### **SOLDERING FOOTPRINT\***



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